

600V N-ch Planar MOSFET

General Features

- RoHS Compliant
- ightharpoonup R_{DS(ON),typ.}=0.65 Ω @V_{GS}=10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

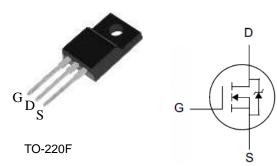
- Adaptor
- Charger
- > SMPS Standby Power

Ordering Information

<u> </u>									
Part Number	Package	Brand							
PSA10N60C	TO-220F	Z							

Lead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ.}	I _D
600V	0.65Ω	10A



Package No to Scale

T_C=25 °C unless otherwise specified

Absolute Maximum Ratings

Symbol	Parameter	Value	Unit	
Symbol	Parameter	PSA10N60C	- Onit	
V _{DSS}	Drain-to-Source Voltage	600	V	
V _{GSS}	Gate-to-Source Voltage	±20		
I _D	Continuous Drain Current	10	Λ.	
I _{DM}	Pulsed Drain Current at V _{GS} =10V	40	_ A	
E _{AS}	Single Pulse Avalanche Energy	800	mJ	
В	Power Dissipation	69	W	
P_{D}	Derating Factor above 25℃	0.55	W/°C	
T _L	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	$^{\circ}$	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	Max. Value	Unit	
Symbol Parameter		PSA10N60C	Oillt	
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	1.8	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	C/VV	



Electrical Characteristics

OFF Characteristics

T_J =25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	600			V	V _{GS} =0V, I _D =250uA
I _{DSS} Drain-to-Source Leakage Current	During to Committee of the Committee of			1		V _{DS} =480V, V _{GS} =0V
			100		V_{DS} =600V, V_{GS} =0V, T_{J} =125°C	
I _{GSS} Gate-to-Source	Cata to Source Leekage Current			+0.1	uA	V _{GS} =+30V, V _{DS} =0V
	Gate-to-Source Leakage Current			-0.1		V _{GS} =-30V, V _{DS} =0V

ON Characteristics

T_J =25 °C unless otherwise specified

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Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		0.65	0.75	Ω	V _{GS} =10V, I _D =5.0A
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_{D}=250uA$
gfs	Forward Transconductance		13		S	Vps=30V,Ip=5.0A

Dynamic Characteristics

Essentially independent of operating temperature

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Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		1360			V_{GS} =0V, V_{DS} =25V, f=1.0MH _Z
C _{rss}	Reverse Transfer Capacitance		13		pF	
C _{oss}	Output Capacitance		135			
Qg	Total Gate Charge		25			
Q _{gs}	Gate-to-Source Charge		7.5		nC	$V_{DD}=300V$, $I_{D}=10A$, $V_{GS}=0$ to 10V
Q_{gd}	Gate-to-Drain (Miller) Charge		7.0			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		15		ns	V_{DD} =300V, I_{D} =10A, V_{GS} =10V Rg =9.1 Ω
trise	Rise Time		25			
td(OFF)	Turn-Off Delay Time		50			
tfall	Fall Time		30			3



Source-Drain Body Diode Characteristics $T_J=25\,^{\circ}\mathbb{C}$ unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]			10	А	Integral pn-diode in MOSFET
I _{SM}	Pulsed Source Current ^[2]			40		
V_{SD}	Diode Forward Voltage			1.5	V	I _S =10A, V _{GS} =0V
trr	Reverse Recovery Time		430		ns	Vgs=0V
Qrr	Reverse Recovery Charge		2.2		uC	I=10A, di/dt=100A/μs

Note:

^[1] T_J =+25°C to +150°C [2] Pulse width≤380µs; duty cycle≤2%.



Typical Characteristics

Figure 1. Maximum Transient Thermal Impedance

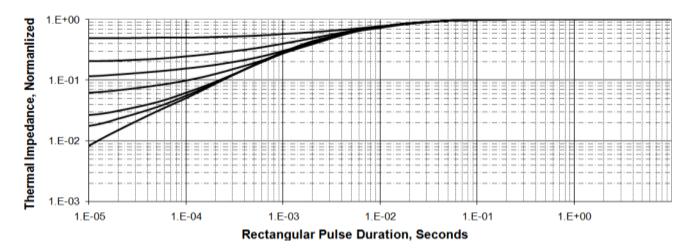


Figure 2. Max. Power Dissipation vs Case Temperature

Tc, Case Temperature

Case Temperature

70

60

40

20

10

25

50

75

100

125

150

Tc, Case Temperature, °C

Figure 3 .Maximum Continuous Drain Current vs Tc

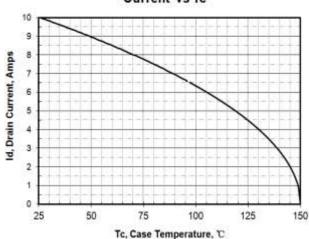


Figure 4. Output Characteristics

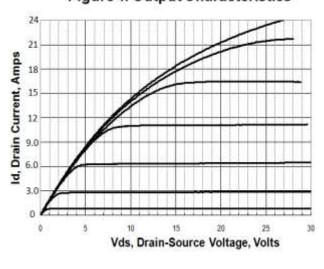
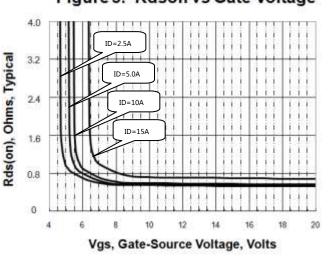


Figure 5. Rdson vs Gate Voltage





Typical Characteristics(Cont.)

Figure 6. Peak Current Capability

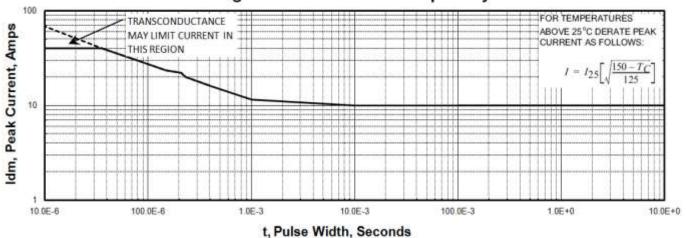


Figure 7. Transfer Characteristics

Figure 8. Unclamped Inductive Switching

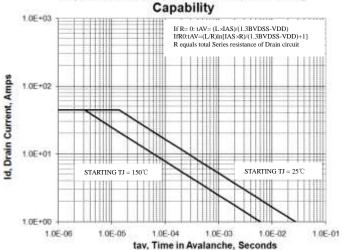


Figure 9. Drain to Source ON Resistance vs Drain Current

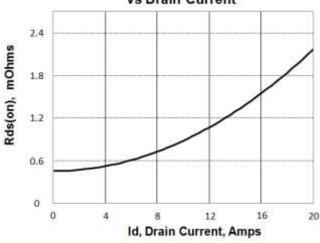
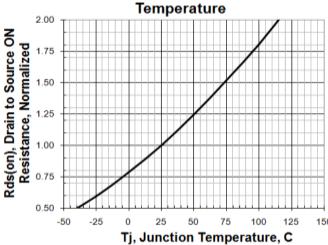


Figure 10. Rdson vs Junction





Typical Characteristics(Cont.)

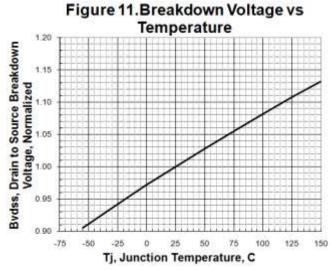


Figure 12. Threshold Voltage vs

Temperature

1 10

1 10

0 95

0 90

0 85

0 75

0 70

0 85

-75

50

25

0 25

0 25

0 75

100

125

150

Tj. Junction Temperature, C

Figure 13 . Maximum Safe Operating Area

1E+02

1E+01

1E+00

1E-01

1E-02

1.0E-01

1.0E+00

1.0E+01

1.0E+02

1.0E+03

Vds, Drain Source Voltage, Volts Figure 15 . Typical Gate Charge

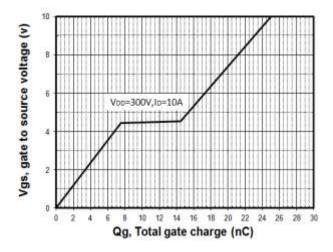
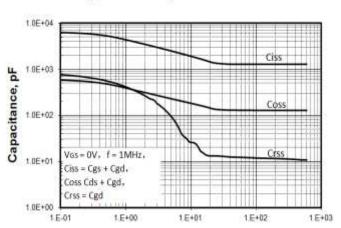
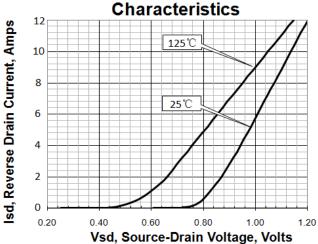


Figure 14. Capacitance vs Vds



Vds, Drain to Source Voltage, Volts
Figure 16.Body Diode Transfer
Characteristics





Test Circuits and Waveforms

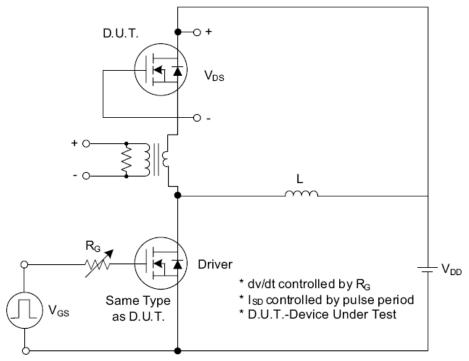


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

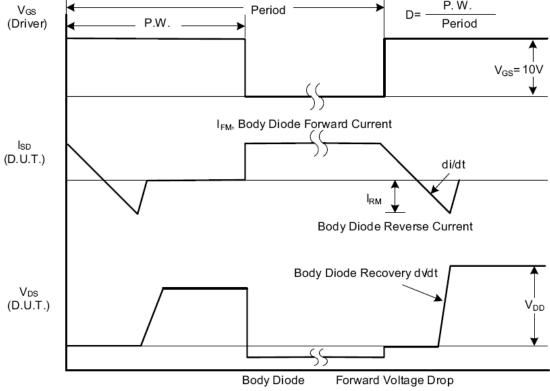


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

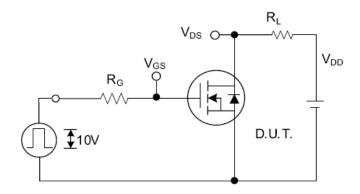


Fig. 2.1 Switching Test Circuit

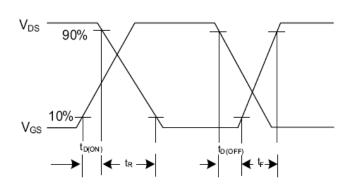


Fig. 2.2 Switching Waveforms

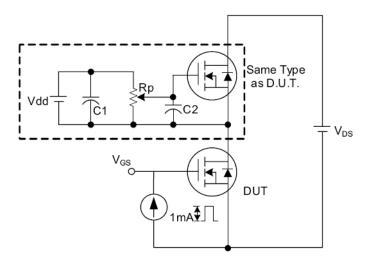


Fig. 3 . 1 Gate Charge Test Circuit

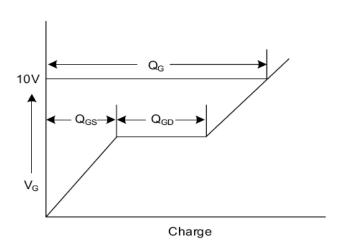


Fig. 3.2 Gate Charge Waveform

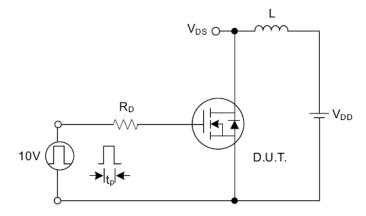


Fig. 4.1 Unclamped Inductive Switching Test Circuit

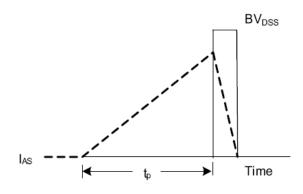


Fig. 4.2 Unclamped Inductive Switching Waveforms



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